

POWER MOS FET FIELD EFFECT POWER TRANSISTOR

IRFD122,123

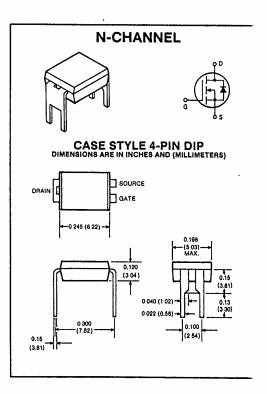
1.1 AMPERES 100, 60 VOLTS RDS(ON) = 0.4 Ω

This series of N-Channel Enhancement-mode Power MOSFETs utilizes GE's advanced Power DMOS technology to achieve low on-resistance with excellent device ruggedness and reliability.

This design has been optimized to give superior performance in most switching applications including: switching power supplies, inverters, converters and solenoid/relay drivers. Also, the extended safe operating area with good linear transfer characteristics makes it well suited for many linear applications such as audio amplifiers and servo motors.

Features

- Polysilicon gate Improved stability and reliability
- No secondary breakdown Excellent ruggedness
- Ultra-fast switching Independent of temperature
- Voltage controlled High transconductance
- Low input capacitance Reduced drive requirement
- Excellent thermal stability Ease of paralleling



maximum ratings (T_A = 25°C) (unless otherwise specified)

RATING	SYMBOL	IRFD122	IRFD123	UNITS	
Drain-Source Voltage	V _{DSS}	100	60	Volts	
Drain-Gate Voltage, R _{GS} = 1MΩ	V _{DGR}	100	60	Volts	
Continuous Drain Current @ T _A = 25°C ⁽¹⁾ @ T _A = 100°C ⁽¹⁾	I _D	1.1 0.70	1.1 0.70	A	
Pulsed Drain Current ⁽²⁾	IDM	4.4	4.4	A	
Gate-Source Voltage	V _{GS}	±20	±20	Volts	
Total Power Dissipation @ T _A = 25°C Derate Above 25°C	PD	1.0 8	1.0 8	Watts mW/°C	
Operating and Storage Junction Temperature Range	T _J , T _{STG}	-55 to 150	-55 to 150	°C	

thermal characteristics

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Thermal Resistance, Junction to Ambient(1)	$R_{ heta JA}$	125	125	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/4" from Case for 5 Seconds	ΤL	300	, 300	°C

⁽¹⁾ Device mounted to vertical pc board in free air with drain lead soldered to 0.20 in² minimum copper run area.

(2) Repetitive Rating: Pulse width limited by max. junction temperature.

electrical characteristics (T_A = 25°C) (unless otherwise specified)

CHARACTERISTIC	SYMBOL	MIN	TYP	MAX	UNIT
off characteristics					
Drain-Source Breakdown Voltage IRFD122 (VGS = 0V, I _D = 250 µA) IRFD123	BVDSS	100 60		_	Volts
Zero Gate Voltage Drain Current (V _{DS} = Max Rating, V _{GS} = 0V, T _A = 25°C) (V _{DS} = Max Rating, × 0.8, V _{GS} = 0V, T _A = 125°C)	IDSS		<u>-</u>	250 1000	μΑ
Gate-Source Leakage Current (VGS = ±20V)	IGSS	_	_	. ±500	nA
on characteristics*				•	!
Gate Threshold Voltage $T_A = 25^{\circ}C$ $(V_{DS} = V_{GS}, I_D = 250 \mu A)$	V _{GS(TH)}	2.0	_	4.0	Volts
On-State Drain Current (V _{GS} = 10V, V _{DS} = 10V)	I _{D(ON)}	1.1			А
Static Drain-Source On-State Resistance (VGS = 10V, ID = 0.6A)	R _{DS(ON)}	_	0.30	0.40	Ohms
Forward Transconductance (V _{DS} = 10V, I _D = 0.6A)	9fs	.63	1.0	_	mhos

dynamic characteristics

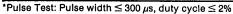
Input Capacitance	V _{GS} = 0V	Ciss	_	410	600	ρF
Output Capacitance	V _{DS} = 25V	Coss	_	160	400	pF
Reverse Transfer Capacitance	f = 1 MHz	C _{rss}		40	100	pF

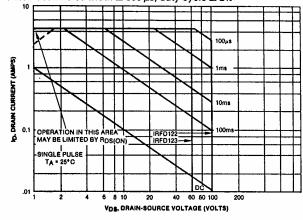
switching characteristics*

Turn-on Delay Time	V _{DS} = 30V	td(on)	<u> </u>	15	·	ns
Rise Time	I _D = 0.6A, V _{GS} = 15V	t _r	_	30		ns
Turn-off Delay Time	R_{GEN} = 50 Ω , R_{GS} = 12.5 Ω	t _{d(off)}		25	_	ns
Fall Time	$(R_{GS} (EQUIV.) = 10\Omega)$	tf		10	_	ns

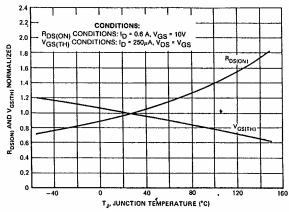
source-drain diode ratings and characteristics*

Continuous Source Current		Is		-	1.1	A
Pulsed Source Current		I _{SM}	-	-	4.4	Α
Diode Forward Voltage (T _A = 25°C, V _{GS} = 0V)	l _S = 1.1A	V _{SD}	_	0.6	2.3	Volts
Reverse Recovery Time (I _S = 1.3A, di _S /dt = 100A/ μ s, T _A = 125°C)		t _{rr} Q _{RR}	_	75 0.7	_	ns μC





MAXIMUM SAFE OPERATING AREA



TYPICAL NORMALIZED $R_{DS[ON]}$ AND $V_{GS[TH]}$ VS. TEMP.